



80V +175°C N-CHANNEL ENHANCEMENT MODE MOSFET

Product Summary

BV _{DSS}	R _{DS(ON)} Max	I _D Max T _C = +25°C
001/	6.9mΩ @ V _{GS} = 10V	52A
80V	10.4mΩ @ V _{GS} = 4.5V	42A

Description and Applications

This MOSFET is designed to meet the stringent requirements of automotive applications. It is qualified to AEC-Q101, supported by a PPAP and is ideal for use in:

- Backlighting
- Power Management Functions
- DC-DC Converters

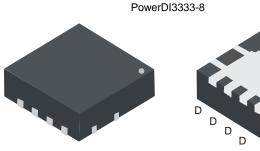
Features and Benefits

- Rated to +175°C Ideal for High Ambient Temperature Environments
- Low R_{DS(ON)} Ensures On-State Losses are Minimized
- Excellent Q_{gd} x R_{DS(ON)} Product (FOM)
- Advanced Technology for DC-DC Converts
- Small Form Factor Thermally Efficient Package Enables Higher Density End Products
- Occupies Just 33% of the Board Area Occupied by SO-8 Enabling Smaller End Product
- 100% Unclamped Inductive Switching (UIS) Test in Production Ensures More Reliable and Robust End Application
- Lead-Free Finish; RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- The DMTH8008LFGQ is suitable for automotive applications requiring specific change control; this part is AEC-Q101 qualified, PPAP capable, and manufactured in IATF 16949 certified facilities.

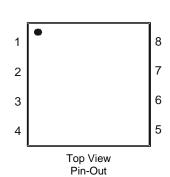
https://www.diodes.com/quality/product-definitions/

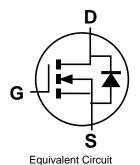
Mechanical Data

- Case: PowerDI[®]3333-8
- Case Material: Molded Plastic, "Green" Molding Compound. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminal Connections Indicator: See Diagram
- Terminal Finish Matte Tin Annealed over Copper Leadframe.
 Solderable per MIL-STD-202, Method 208(3)
- Weight: 0.072 grams (Approximate)









Ordering Information (Note 4)

Part Number	Case	Packaging		
DMTH8008LFGQ-7	PowerDI3333-8	2,000/Tape & Reel		
DMTH8008LFGQ-13	PowerDI3333-8	3,000/Tape & Reel		

Notes:

- 1. EU Directive 2002/95/EC (RoHS), 2011/65/EU (RoHS 2) & 2015/863/EU (RoHS 3) compliant. All applicable RoHS exemptions applied.
- 2. See https://www.diodes.com/quality/lead-free/ for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. For packaging details, go to our website at https://www.diodes.com/design/support/packaging/diodes-packaging/.

Marking Information



HX8 = Product Type Marking Code YYWW = Date Code Marking YY = Last Two Digits of Year (ex: 19 = 2019) WW = Week Code (01 to 53)

PowerDI is a registered trademark of Diodes Incorporated.



Maximum Ratings (@TA = +25°C, unless otherwise specified.)

Characteristic	Symbol	Value	Unit	
Drain-Source Voltage	VDSS	80	V	
Gate-Source Voltage	Vgss	±20	V	
Continuous Drain Current (Note 7) $V_{GS} = 10V$ $T_{C} = +25^{\circ}C$ $T_{C} = +100^{\circ}C$		lo	52 37	Α
Continuous Drain Current (Note 6) $V_{GS} = 10V$ $T_A = +25^{\circ}C$ $T_A = +100^{\circ}C$		lo	17 12	А
Maximum Continuous Body Diode Forward Current (Note 6)	Is	45	Α	
Pulsed Drain Current (10µs Pulse, Duty Cycle = 1%)	I _{DM}	200	Α	
Pulsed Body Diode Forward Current (10µs Pulse, Duty Cycle = 1%	I _{SM}	200	Α	
Avalanche Current, L = 1mH (Note 8)	las	18	A	
Avalanche Energy, L = 1mH (Note 8)	E _{AS}	162	mJ	

Thermal Characteristics

Characteristic		Symbol	Value	Unit
Total Power Dissipation (Note 5)	T _A = +25°C	PD	1.2	W
Thermal Resistance, Junction to Ambient (Note 5)	Steady State	$R_{\theta JA}$	126	°C/W
Total Power Dissipation (Note 6)	T _A = +25°C	PD	3.1	W
Thermal Resistance, Junction to Ambient (Note 6)	Steady State	$R_{ heta JA}$	49	°C/W
Total Power Dissipation (Note 7)	T _C = +25°C	PD	28.3	W
Thermal Resistance, Junction to Case (Note 7)	$R_{ heta JC}$	5.3	°C/W	
Operating and Storage Temperature Range	TJ, TSTG	-55 to +175	°C	

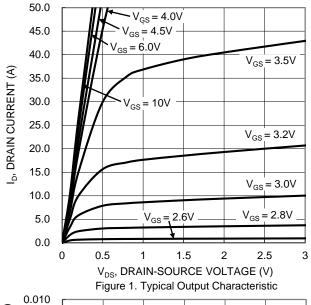
Electrical Characteristics (@TA = +25°C, unless otherwise specified.)

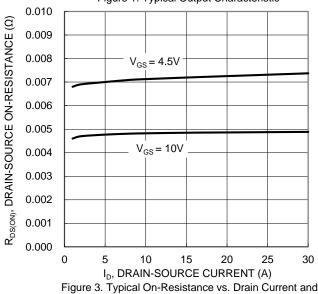
Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition	
OFF CHARACTERISTICS (Note 9)							
Drain-Source Breakdown Voltage	BV _{DSS}	80		_	V	$V_{GS} = 0V$, $I_D = 1mA$	
Zero Gate Voltage Drain Current	IDSS	_		1	μA	V _{DS} = 64V, V _{GS} = 0V	
Gate-Source Leakage	Igss	_	_	±100	nA	V _G S = ±20V, V _D S = 0V	
ON CHARACTERISTICS (Note 9)	_	•					
Gate Threshold Voltage	V _{GS(TH)}	1.2		2.5	V	$V_{DS} = V_{GS}$, $I_D = 1mA$	
Static Drain-Source On-Resistance	Program	_	5.3	6.9	mΩ	V _G S = 10V, I _D = 20A	
Static Dialii-Source On-Nesistance	RDS(ON)	_	7.9	10.4	11177	V _{GS} = 4.5V, I _D = 10A	
Diode Forward Voltage	Vsp	_	0.8	1.2	V	Vgs = 0V, Is = 20A	
DYNAMIC CHARACTERISTICS (Note 10)							
Input Capacitance	Ciss	_	2254	_		V _{DS} = 40V, V _{GS} = 0V, f = 1MHz	
Output Capacitance	Coss	_	745	_	рF		
Reverse Transfer Capacitance	Crss	_	31	_			
Gate Resistance	Rg	_	1.98	_	Ω	$V_{DS} = 0V$, $V_{GS} = 0V$, $f = 1MHz$	
Total Gate Charge (V _{GS} = 4.5V)	Qg	_	18.3	_			
Total Gate Charge (V _{GS} = 10V)	Qg	_	37.7	_	nC	\/ 10\/ I- 110	
Gate-Source Charge	Qgs	_	5.3	_	IIC	$V_{DS} = 40V, I_{D} = 14A$	
Gate-Drain Charge	Q_{gd}	_	7.8	_			
Turn-On Delay Time	t _{D(ON)}	_	6.9	_			
Turn-On Rise Time	t _R	_	12	_	20	V _{DD} = 40V, V _{GS} = 10V,	
Turn-Off Delay Time	tD(OFF)	_	37	_	ns	$I_D = 14A$, $R_G = 6\Omega$	
Turn-Off Fall Time	tF	_	21	_			
Body Diode Reverse Recovery Time	trr	_	42	_	ns	la 110 di/dt 1000/ug	
Body Diode Reverse Recovery Charge	Q _{RR}	_	53	_	$\frac{100}{\text{nC}}$ Is = 14A, di/dt = 100A/µs		

5. Device mounted on FR-4 PC board, with minimum recommended pad layout, single sided.

- 6. Device mounted on FR-4 substrate PC board, 2oz copper, with thermal bias to bottom layer 1inch square copper plate.
- 7. Thermal resistance from junction to soldering point (on the exposed drain pad).
- 8. I_{AS} and E_{AS} ratings are based on low frequency and duty cycles to keep T_J = +25°C.
 9. Short duration pulse test used to minimize self-heating effect.
 10. Guaranteed by design. Not subject to product testing.







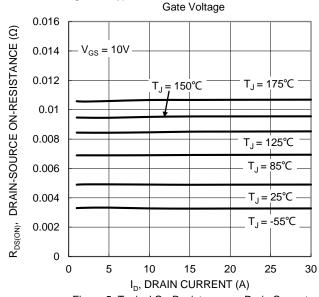
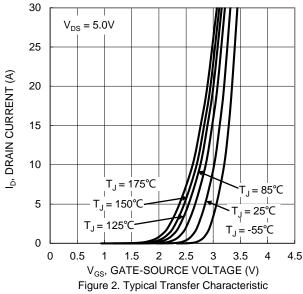
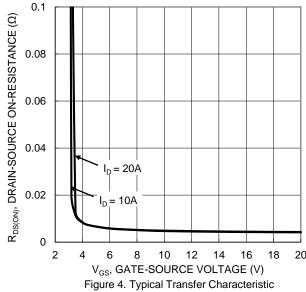


Figure 5. Typical On-Resistance vs. Drain Current and Temperature





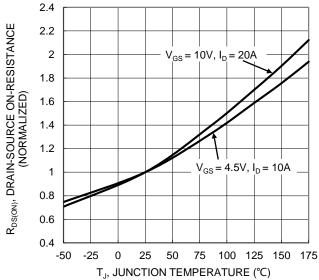


Figure 6. On-Resistance Variation with Temperature





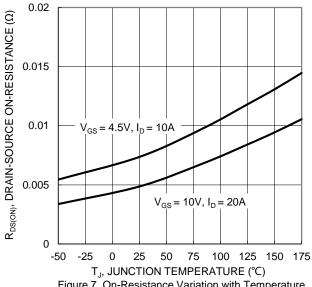


Figure 7. On-Resistance Variation with Temperature

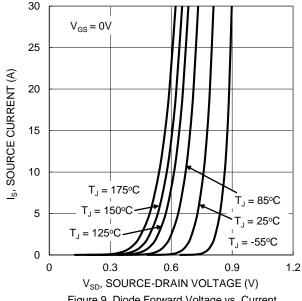


Figure 9. Diode Forward Voltage vs. Current 10 8 6 $V_{GS}(V)$ 4 $V_{DS} = 40V, I_{D} = 14A$ 2 0 5 10 15 20 25 30 35 40 Q_g (nC)

Figure 11. Gate Charge

3 $V_{\text{GS(TH)}}$, GATE THRESHOLD VOLTAGE (V) 2.8 2.6 2.4 2.2 2 1.8 $I_D = 1 \text{mA}$ 1.6 1.4 $I_{D} = 250 \mu A$ 1.2 1 8.0 0.6 0.4 -25 -50 25 50 75 100 125 150 175 T_J, JUNCTION TEMPERATURE (°C)

Figure 8. Gate Threshold Variation vs. Junction Temperature

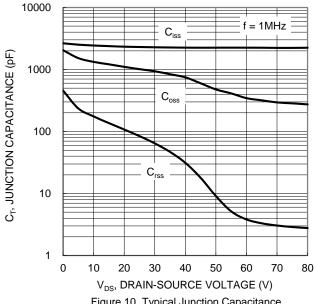


Figure 10. Typical Junction Capacitance

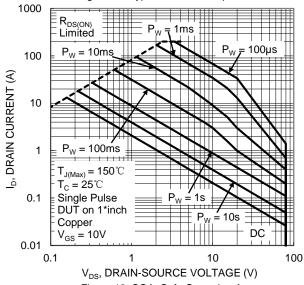


Figure 12. SOA, Safe Operation Area



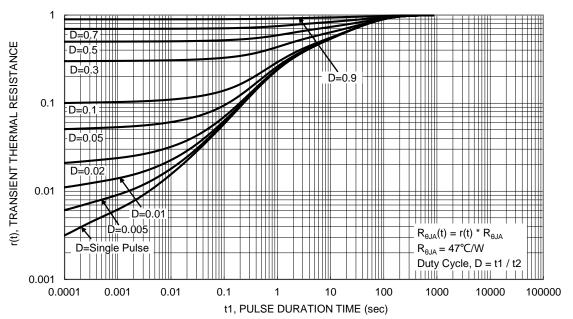


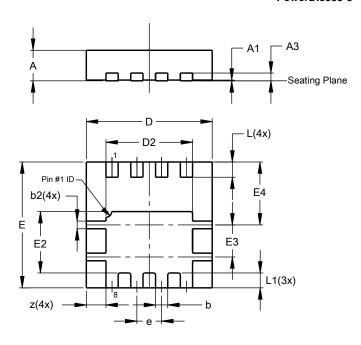
Figure 13. Transient Thermal Resistance



Package Outline Dimensions

Please see http://www.diodes.com/package-outlines.html for the latest version.

PowerDI3333-8

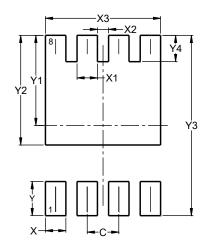


PowerDI3333-8					
Dim	Min	Max	Тур		
Α	0.75	0.85	0.80		
A1	0.00	0.05	0.02		
A3	_	-	0.203		
b	0.27	0.37	0.32		
b2	0.15	0.25	0.20		
D	3.25	3.35	3.30		
D2	2.22	2.32	2.27		
Е	3.25	3.35	3.30		
E2	1.56	1.66	1.61		
E3	0.79	0.89	0.84		
E4	1.60	1.70	1.65		
е	_	_	0.65		
L	0.35	0.45	0.40		
L1	_	_	0.39		
Z	_	_	0.515		
All Dimensions in mm					

Suggested Pad Layout

Please see http://www.diodes.com/package-outlines.html for the latest version.

PowerDI3333-8



Dimensions	Value (in mm)
С	0.650
X	0.420
X1	0.420
X2	0.230
Х3	2.370
Y	0.700
Y1	1.850
Y2	2.250
Y3	3.700
Y4	0.540



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